

<b>Notice of References Cited</b>	Application/Control No. 10/661,724	Applicant(s)/Patent Under Reexamination TENNEY ET AL.	
	Examiner JOHN PAK	Art Unit 1616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,566,392	05-2003	Okada et al.	514/461
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	59-98008	06-1984	JP	USUI International Ind.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	JAPIO abstract 1984-098008 (1984).
	V	HCAPLUS abstract 1984-546140 (1984).
	W	The Merck Index, 12 <sup>th</sup> ed., Merck & Co., Inc., Whitehouse Station, NJ, 1996, page 683.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.